

## Power MOSFET

| PRODUCT SUMMARY           |                 |     |
|---------------------------|-----------------|-----|
| $V_{DS}$ (V)              | 600             |     |
| $R_{DS(on)}$ ( $\Omega$ ) | $V_{GS} = 10$ V | 2.2 |
| $Q_g$ (Max.) (nC)         | 31              |     |
| $Q_{gs}$ (nC)             | 4.6             |     |
| $Q_{gd}$ (nC)             | 17              |     |
| Configuration             | Single          |     |

### FEATURES

- Surface Mount (IRFBC30S, SiHFBC30S)
- Low-Profile Through-Hole (IRFBC30L, SiHFBC30L)
- Available in Tape and Reel (IRFBC30S, SiHFBC30S)
- Dynamic  $dV/dt$  Rating
- 150 °C Operating Temperature
- Fast Switching
- Fully Avalanche Rated
- Lead (Pb)-free Available



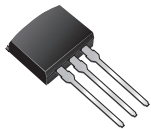
Available  
**RoHS\***  
COMPLIANT

### DESCRIPTION

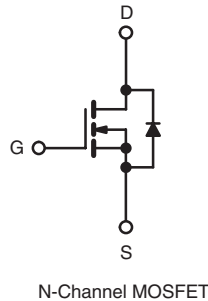
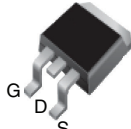
Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The D<sup>2</sup>PAK is a surface mount power package capable of the accommodating die sizes up to HEX-4. It provides the highest power capability and the lowest possible on-resistance in any existing surface mount package. The D<sup>2</sup>PAK is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0 W in a typical surface mount application. The through-hole version (IRFBC30L, SiHFBC30L) is available for low-profile applications.

I<sup>2</sup>PAK (TO-262)



D<sup>2</sup>PAK (TO-263)



| ORDERING INFORMATION |                             |  |                             |
|----------------------|-----------------------------|--|-----------------------------|
| Package              | D <sup>2</sup> PAK (TO-263) | D <sup>2</sup> PAK (TO-263)                                | I <sup>2</sup> PAK (TO-262) |
| Lead (Pb)-free       | IRFBC30SPbF<br>SiHFBC30S-E3 | IRFBC30STRLPbF <sup>a</sup><br>SiHFBC30STL-E3 <sup>a</sup> | IRFBC30LPbF<br>SiHFBC30L-E3 |
| SnPb                 | IRFBC30S<br>SiHFBC30S       | -<br>-   | IRFBC30L<br>SiHFBC30L       |

#### Note

a. See device orientation.

| ABSOLUTE MAXIMUM RATINGS $T_C = 25$ °C, unless otherwise noted |                  |                  |      |   |
|--|------------------|------------------|------|---|
| PARAMETER  | SYMBOL           | LIMIT            | UNIT |   |
| Drain-Source Voltage   | $V_{DS}$         | 600              | V    |   |
| Gate-Source Voltage  | $V_{GS}$         | $\pm 20$         |      |   |
| Continuous Drain Current <sup>e</sup>                          | $V_{GS}$ at 10 V | $T_C = 25$ °C    | 3.6  | A |
|  |                  | $T_C = 100$ °C   | 2.3  |   |
| Pulsed Drain Current <sup>a, e</sup>                           | $I_{DM}$         | 14               |      |   |
| Linear Derating Factor   |                  | 0.59             | W/°C |   |
| Single Pulse Avalanche Energy <sup>b, e</sup>                  | $E_{AS}$         | 290              | mJ   |   |
| Avalanche Current <sup>a</sup>                                 | $I_{AR}$         | 3.6              | A    |   |
| Repetitive Avalanche Energy <sup>a</sup>                       | $E_{AR}$         | 7.4              | mJ   |   |
| Maximum Power Dissipation                                      | $P_D$            | $T_A = 25$ °C    | 3.1  | W |
|  |                  | $T_C = 25$ °C    | 74   |   |
| Peak Diode Recovery $dV/dt$ <sup>c, e</sup>                    | $dV/dt$          | 3.0              | V/ns |   |
| Operating Junction and Storage Temperature Range               | $T_J, T_{stg}$   | - 55 to + 150    | °C   |   |
| Soldering Recommendations (Peak Temperature)                   | for 10 s         | 300 <sup>d</sup> |      |   |

#### Notes


- Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- $V_{DD} = 50$  V, starting  $T_J = 25$  °C,  $L = 41$  mH,  $R_G = 25$   $\Omega$ ,  $I_{AS} = 3.6$  A (see fig. 12).
- $I_{SD} \leq 3.6$  A,  $dI/dt \leq 60$  A/ $\mu$ s,  $V_{DD} \leq V_{DS}$ ,  $T_J \leq 150$  °C.
- 1.6 mm from case.
- Uses IRFBC30/SiHFBC30 data and test conditions.

\* Pb containing terminations are not RoHS compliant, exemptions may apply

| THERMAL RESISTANCE RATINGS   |            |      |      |      |
|--|------------|------|------|------|
| PARAMETER  | SYMBOL     | TYP. | MAX. | UNIT |
| Maximum Junction-to-Ambient (PCB Mounted, steady-state) <sup>a</sup> | $R_{thJA}$ | -    | 40   | °C/W |
| Maximum Junction-to-Case (Drain)                                     | $R_{thJC}$ | -    | 1.7  |      |

### Note

- a. When mounted on 1" square PCB (FR-4 or G-10 material).  
For recommended footprint and soldering techniques refer to application note #AN-994.

| SPECIFICATIONS $T_J = 25\text{ }^\circ\text{C}$ , unless otherwise noted |                     |  |   |      |      |           |               |
|--|---------------------|--|---|------|------|-----------|---------------|
| PARAMETER  | SYMBOL              | TEST CONDITIONS  |   | MIN. | TYP. | MAX.      | UNIT          |
| <b>Static</b>  |                     |  |   |      |      |           |               |
| Drain-Source Breakdown Voltage   | $V_{DS}$            | $V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$  |   | 600  | -    | -         | V             |
| $V_{DS}$ Temperature Coefficient   | $\Delta V_{DS}/T_J$ | Reference to $25\text{ }^\circ\text{C}$ , $I_D = 1\text{ mA}^c$  |   | -    | 0.62 | -         | V/°C          |
| Gate-Source Threshold Voltage  | $V_{GS(th)}$        | $V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$  |   | 2.0  | -    | 4.0       | V             |
| Gate-Source Leakage  | $I_{GSS}$           | $V_{GS} = \pm 20\text{ V}$   |   | -    | -    | $\pm 100$ | nA            |
| Zero Gate Voltage Drain Current  | $I_{DSS}$           | $V_{DS} = 600\text{ V}, V_{GS} = 0\text{ V}$   |   | -    | -    | 100       | $\mu\text{A}$ |
|  |                     | $V_{DS} = 480\text{ V}, V_{GS} = 0\text{ V}, T_J = 125\text{ }^\circ\text{C}$  |   | -    | -    | 500       |               |
| Drain-Source On-State Resistance   | $R_{DS(on)}$        | $V_{GS} = 10\text{ V}$   | $I_D = 2.2\text{ A}^b$  | -    | -    | 2.2       | $\Omega$      |
| Forward Transconductance   | $g_{fs}$            | $V_{DS} = 50\text{ V}, I_D = 2.2\text{ A}^c$   |   | 2.5  | -    | -         | S             |
| <b>Dynamic</b>   |                     |  |   |      |      |           |               |
| Input Capacitance  | $C_{iss}$           | $V_{GS} = 0\text{ V}, V_{DS} = 25\text{ V}, f = 1.0\text{ MHz}$ , see fig. 5 <sup>c</sup>  |   | -    | 660  | -         | pF            |
| Output Capacitance   | $C_{oss}$           |  |   | -    | 86   | -         |               |
| Reverse Transfer Capacitance   | $C_{riss}$          |  |   | -    | 19   | -         |               |
| Total Gate Charge  | $Q_g$               | $V_{GS} = 10\text{ V}$   | $I_D = 3.6\text{ A}, V_{DS} = 360\text{ V}$ , see fig. 6 and 13 <sup>b, c</sup> | -    | -    | 31        | nC            |
| Gate-Source Charge   | $Q_{gs}$            |  |   | -    | -    | 4.6       |               |
| Gate-Drain Charge  | $Q_{gd}$            |  |   | -    | -    | 17        |               |
| Turn-On Delay Time   | $t_{d(on)}$         | $V_{DD} = 300\text{ V}, I_D = 3.6\text{ A}, R_G = 12\text{ }\Omega, R_D = 82\text{ }\Omega$ , see fig. 10 <sup>b, c</sup>                            |   | -    | 11   | -         | ns            |
| Rise Time  | $t_r$               |  |   | -    | 13   | -         |               |
| Turn-Off Delay Time  | $t_{d(off)}$        |  |   | -    | 35   | -         |               |
| Fall Time  | $t_f$               |  |   | -    | 14   | -         |               |
| Internal Source Inductance   | $L_S$               | Between lead, and center of die contact  |   | -    | 7.5  | -         | nH            |
| <b>Drain-Source Body Diode Characteristics</b>                           |                     |  |   |      |      |           |               |
| Continuous Source-Drain Diode Current                                    | $I_S$               | MOSFET symbol showing the integral reverse p - n junction diode  |   | -    | -    | 3.6       | A             |
| Pulsed Diode Forward Current <sup>a</sup>                                | $I_{SM}$            |  |   | -    | -    | 14        |               |
| Body Diode Voltage   | $V_{SD}$            | $T_J = 25\text{ }^\circ\text{C}, I_S = 3.6\text{ A}, V_{GS} = 0\text{ V}^b$  |   | -    | -    | 1.6       | V             |
| Body Diode Reverse Recovery Time   | $t_{rr}$            | $T_J = 25\text{ }^\circ\text{C}, I_F = 3.6\text{ A}, dI/dt = 100\text{ A}/\mu\text{s}^b, c$  |   | -    | 370  | 810       | ns            |
| Body Diode Reverse Recovery Charge                                       | $Q_{rr}$            |  |   | -    | 2.0  | 4.2       | $\mu\text{C}$ |
| Forward Turn-On Time   | $t_{on}$            | Intrinsic turn-on time is negligible (turn-on is dominated by $L_S$ and $L_D$ )  |   |      |      |           |               |

### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).  
b. Pulse width  $\leq 300\text{ }\mu\text{s}$ ; duty cycle  $\leq 2\%$ .  
c. Uses IRFBC30/SiHFBC30 data and test conditions.



## TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

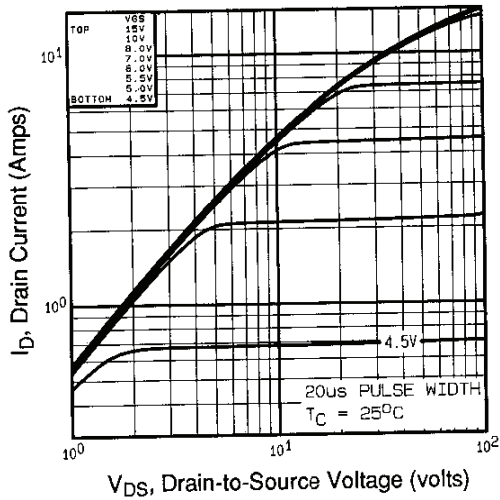


Fig. 1 - Typical Output Characteristics

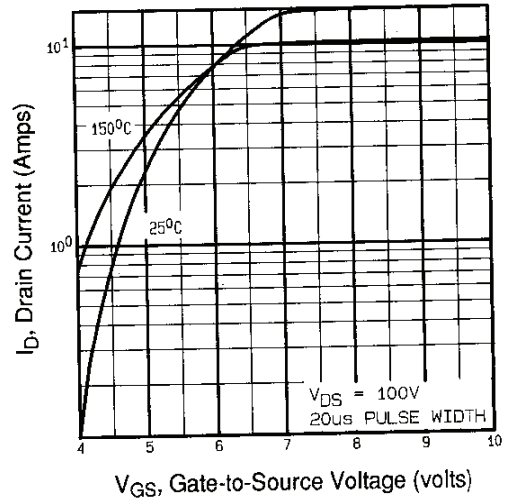


Fig. 3 - Typical Transfer Characteristics

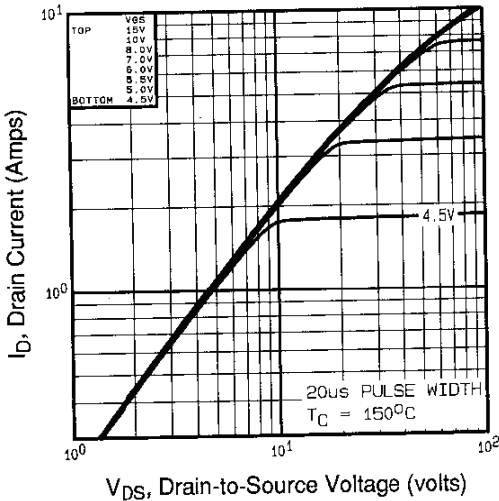


Fig. 2 - Typical Output Characteristics

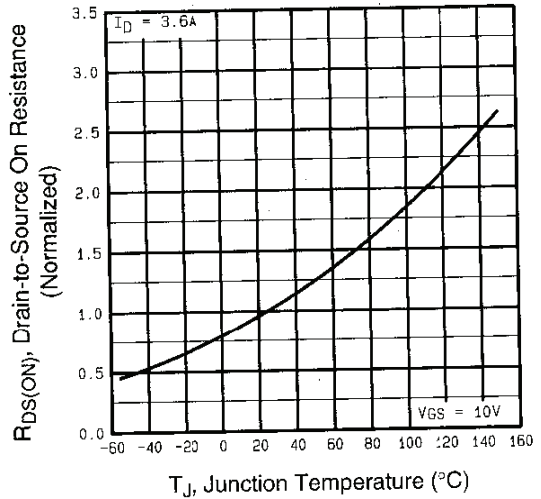


Fig. 4 - Normalized On-Resistance vs. Temperature

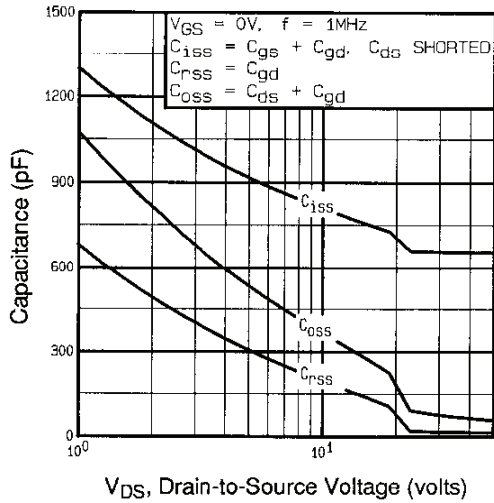


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

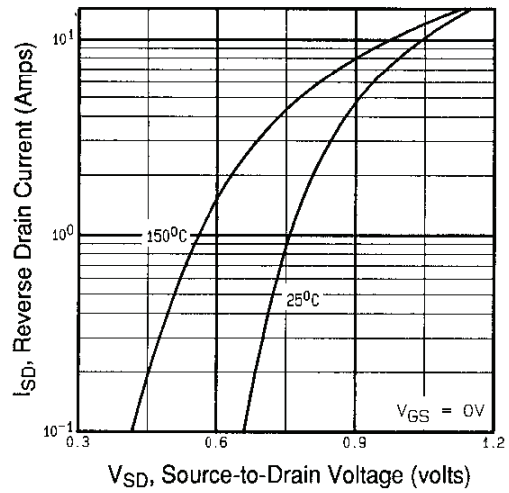


Fig. 7 - Typical Source-Drain Diode Forward Voltage

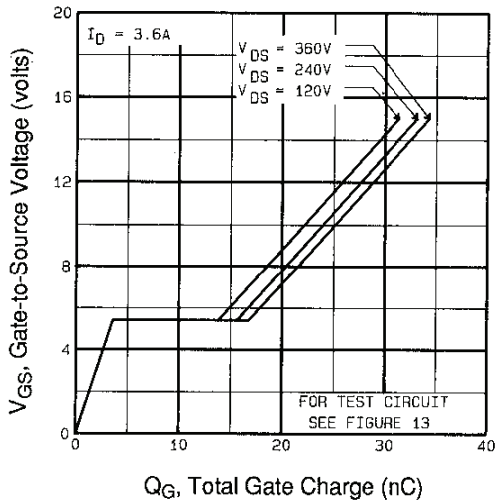


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

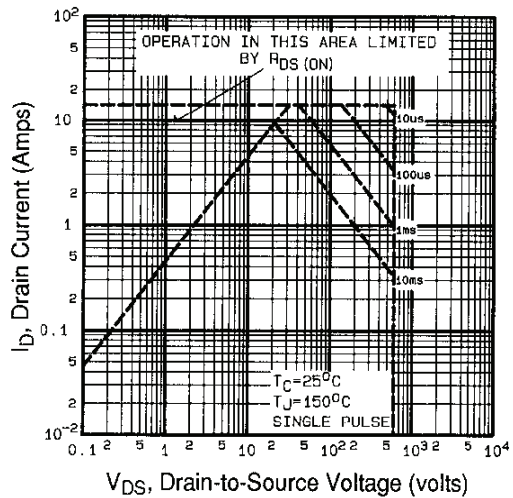


Fig. 8 - Maximum Safe Operating Area

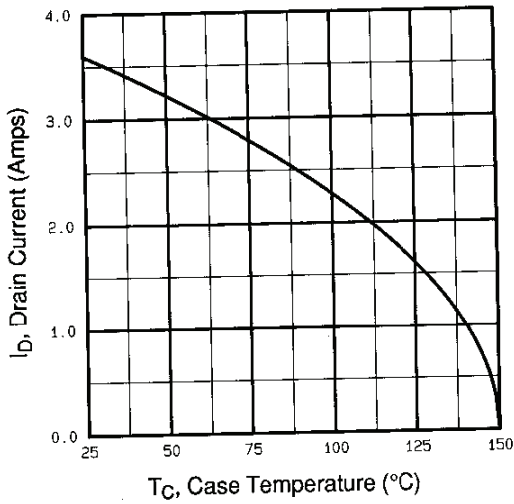


Fig. 9 - Maximum Drain Current vs. Case Temperature



Fig. 10a - Switching Time Test Circuit



Fig. 10b - Switching Time Waveforms

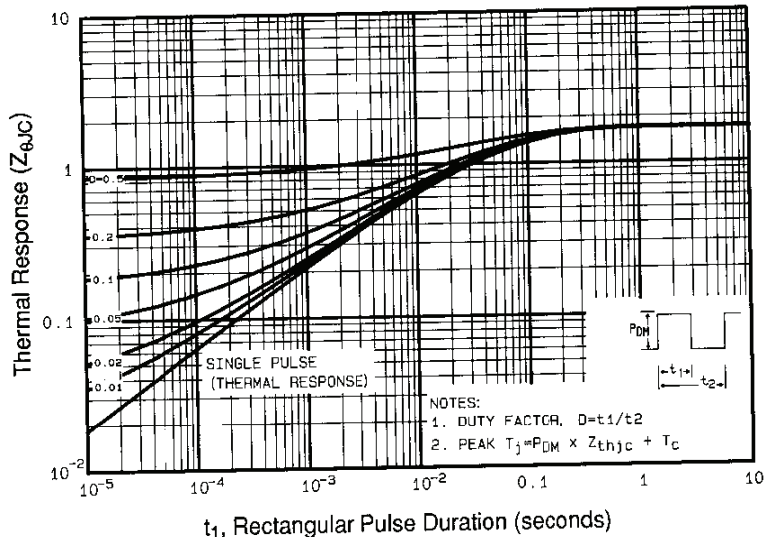


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

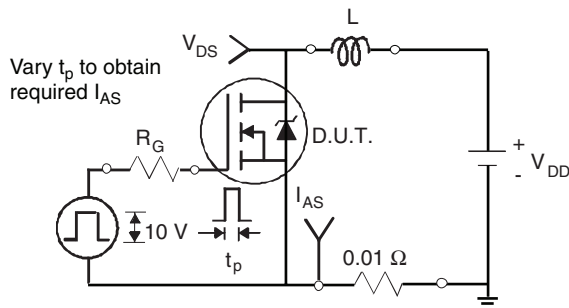


Fig. 12a - Unclamped Inductive Test Circuit

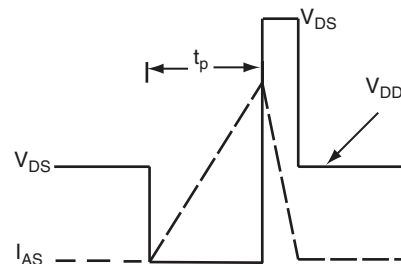


Fig. 12b - Unclamped Inductive Waveforms

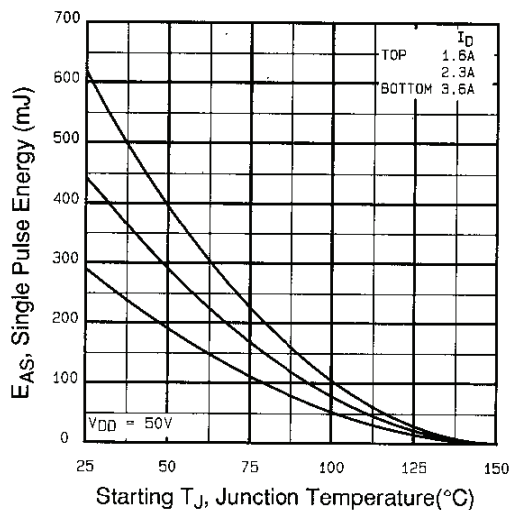


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

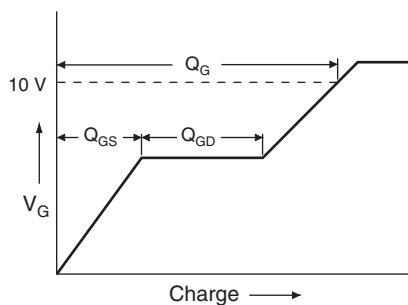


Fig. 13a - Maximum Avalanche Energy vs. Drain Current

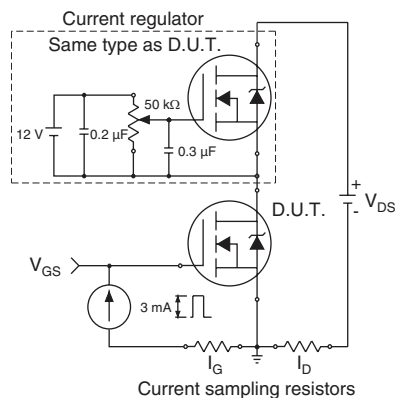
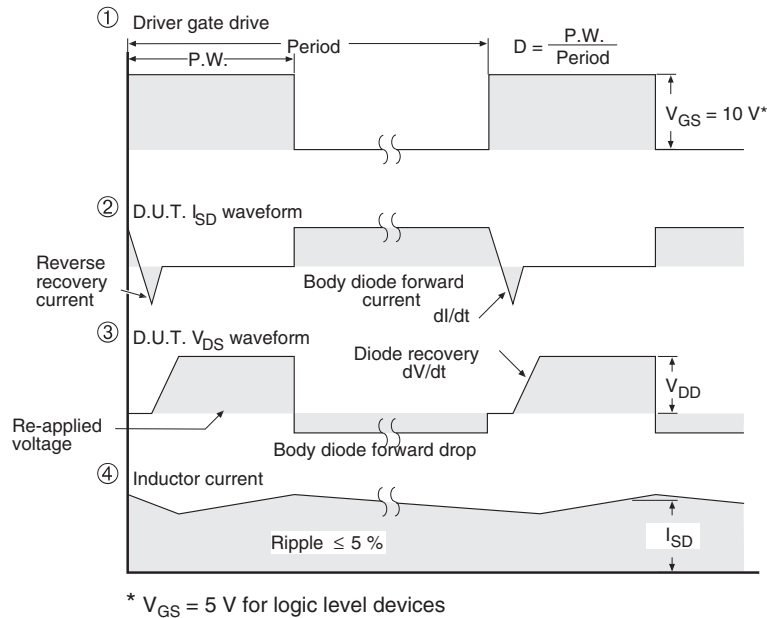
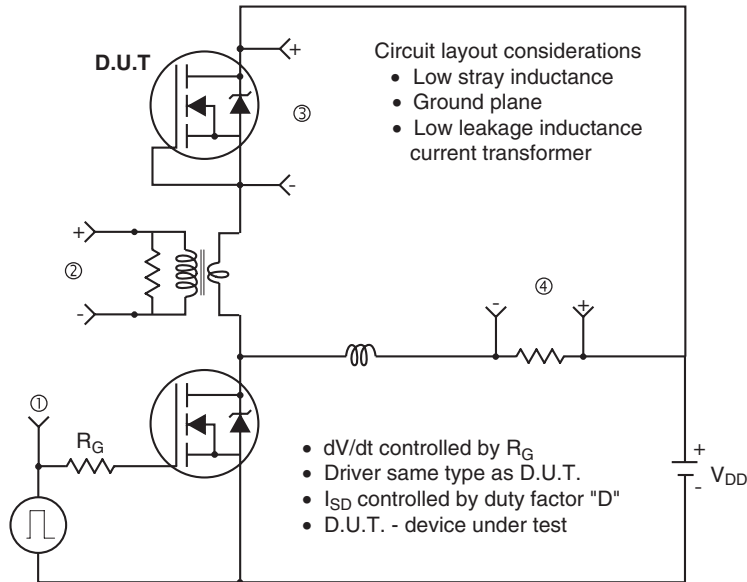


Fig. 13b - Gate Charge Test Circuit

## Peak Diode Recovery dV/dt Test Circuit



**Fig. 14 - For N-Channel**

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